

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/536,512	KIM ET AL.	
Examiner Sin J. Lee		Art Unit 1795		Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,767,689	07-2004	Pavelchek et al.	430/271.1
*	B	US-7,175,974	02-2007	Jung et al.	430/325
*	C	US-7,108,957	09-2006	Jung et al.	430/270.1
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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